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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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: Tetsurou NAKAMURA et al.

Group Art Unit: Not Yet Assigned

Appl. No.

: 10/551,450

(U.S. National Stage of PCT/JP2004/004724)

I.A. Filed

:March 31, 2004

Examiner: Not Yet Assigned

For

: DISPLAY

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
U.S. Patent and Trademark Office
Customer Service Window, Mail Stop AMENDMENT
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and §§1.97-1.98, Applicants hereby bring the following information to the attention of the Examiner in charge of the above-identified application, which includes information cited and discussed in the specification, the International Search Report, and the International Preliminary Examination Report issued in connection with International Patent Application No. PCT/JP2004/004724, of which the present application is the U.S. National Stage Application. Copies of the International Search Report and the International Preliminary Examination Report were enclosed with the papers when entering the U.S. National Stage on September 29, 2005. The Examiner is requested to review these materials to inspect the relevance indicated during international examination with respect to

the documents cited therein. The following is a list of the documents cited in the above-noted documents:

Japanese Laid-open Patent Publication No. 2001-312227, together with an English language Abstract of the same. Applicants note that this document is cited on page 1 of the specification of the above-captioned application;

Japanese Laid-open Patent Publication No. 2000-297089, together with an English language Abstract and partial translation of the same;

Japanese Laid-open Patent Publication No. 2001-100661, together with an English language Abstract and partial translation of the same;

Japanese Laid-open Patent Publication No. 2003-92407, together with an English language Abstract of the same and family member U.S. Patent Application Publication No. 2004/0201018;

Japanese Laid-open Patent Publication No. 2003-59666, together with an English language Abstract of the same and family member U.S. Patent Application Publication No. 2003/15960;

Japanese Laid-open Patent Publication No. 2002-268576, together with an English language Abstract of the same and partial translation of the same;

Japanese Laid-open Patent Publication No. 2002-215101, together with an English language Abstract of the same;

Japanese Laid-open Patent Publication No. 2003-84718, together with an English language Abstract of the same and partial translation of the same; and Japanese Utility Model Laid-open Utility Registration No. HEI 5-58383, together with an English language partial translation of the same.

Further to 37 C.F.R. §1.98 (a)(2)(ii), copies of the U.S. patents and the U.S. patent application publications are not enclosed herewith. However, if copies are needed, the Examiner is respectfully requested to contact the undersigned.

Applicants respectfully request that the Examiner consider the above material and cite the same. Copies of the above-noted foreign documents are attached hereto and all of the above-noted documents are listed on the attached PTO-1449 Form. The Examiner is requested to initial the appropriate spaces on the attached Form and to return a copy of the completed Form to Applicants with the next official communication in the present application.

Applicants note that an Office Action on the merits has not issued in the present application, and thus, no fee is believed necessary to ensure consideration of the submitted material.

Should the Examiner have any questions, the Examiner is invited to contact the undersigned at the below-listed telephone number.

Respectfully Submitted, Tetsurou NAKAMURA et al.

Bruce H. Bernstein Reg. No. 29,027

Steven Wegman Reg. No. 31,438

January 25, 2006 GREENBLUM & BERNSTEIN, P.L.C. 1950 Roland Clarke Place Reston, VA 20191 (703) 716-1191

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INFORMATION DISCLOSURE STATEMENT BY APPLICANT												Applicant Tetsurou NAKAMURA et al.						
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1 English Language Abstract of JP 2001-312227.																		
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EXAMINER DATE CONSIDERED

*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.